

# International **IR** Rectifier

INSULATED GATE BIPOLAR TRANSISTOR WITH  
HYPERFAST DIODE

## Features

- Fast: optimized for medium operating frequencies (1-5 kHz in hard switching, >20kHz in resonant mode).
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than Generation 3.
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft recovery anti-parallel diodes for use in bridge configurations.
- Lead-Free

## Benefits

- Generation 4 IGBT's offer highest efficiency available.
- IGBT's optimized for specific application conditions.
- HEXFRED diodes optimized for performance with IGBT's. Minimized recovery characteristics require less/no snubbing.
- Designed to be a "drop-in" replacement for equivalent industry-standard Generation 3 IR IGBT's.

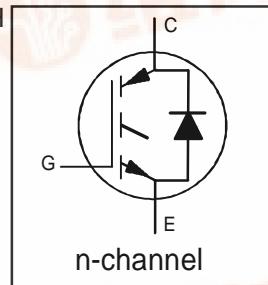
## Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Voltage	600	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	31	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	17	
$I_{CM}$	Pulse Collector Current (Ref.Fig.C.T.5) ①	120	
$I_{LM}$	Clamped Inductive Load current ②	120	
$I_F @ T_C = 100^\circ C$	Diode Continuous Forward Current	12	
$I_{FM}$	Diode Maximum Forward Current	120	
$V_{GE}$	Gate-to-Emitter Voltage	$\pm 20$	V
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	100	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	42	
$T_J$	Operating Junction and Storage Temperature Range	-55 to +150	°C
$T_{STG}$			

## Thermal / Mechanical Characteristics

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case- IGBT	—	—	1.2	°C/W
$R_{\theta CS}$	Case-to-Sink, flat, greased surface	—	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mounted,steady state) ③	—	—	40	
Wt	Weight	—	2.0 (0.07)	—	g (oz.)

PD - 95970  
**IRG4BC30FD-SPbF**  
Fast CoPack IGBT



$V_{CES} = 600V$   
 $V_{CE(on)} \text{ typ.} = 1.59V$   
 $@ V_{GE} = 15V, I_C = 17A$



D2Pak

# IRG4BC30FD-SPbF

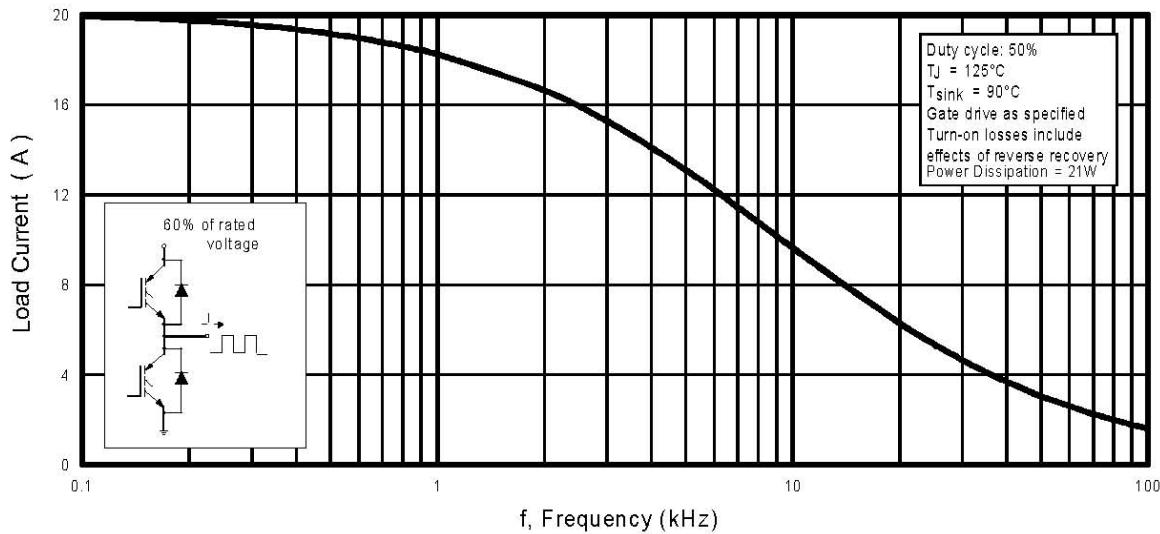
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## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

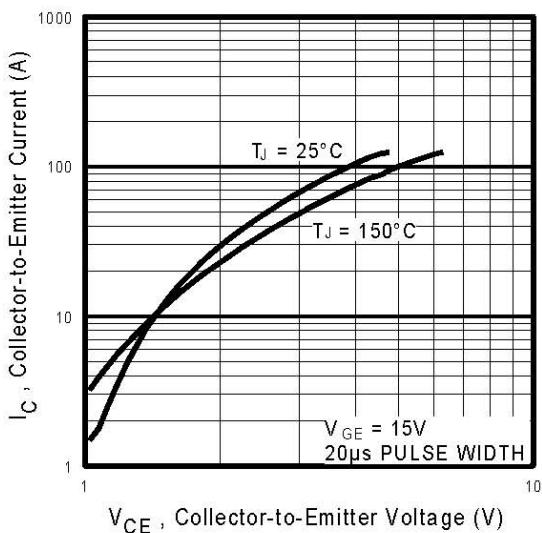
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{CES}}$	Collector-to-Emitter Breakdown Voltage ③	600	—	—	V	$V_{\text{GE}} = 0\text{V}$ , $I_C = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{CES}/\Delta T_J}$	Temperature Coeff. of Breakdown Voltage	—	0.69	—	V/ $^\circ\text{C}$	$V_{\text{GE}} = 0\text{V}$ , $I_C = 1\text{mA}$
$V_{\text{CE}(\text{on})}$	Collector-to-Emitter Voltage	—	1.59	1.8	V	$I_C = 17\text{A}$ $V_{\text{GE}} = 15\text{V}$
		—	1.99	—		$I_C = 31\text{A}$ See Fig. 2, 5
		—	1.7	—		$I_C = 17\text{A}$ , $T_J = 150^\circ\text{C}$
$V_{\text{GE}(\text{th})}$	Gate Threshold Voltage	3.0	—	6.0	V	$V_{\text{CE}} = V_{\text{GE}}$ , $I_C = 250\mu\text{A}$
$\Delta V_{\text{GE}(\text{th})/\Delta T_J}$	Threshold Voltage temp. coefficient	—	-11	—	mV/ $^\circ\text{C}$	$V_{\text{CE}} = V_{\text{GE}}$ , $I_C = 250\mu\text{A}$
$g_{\text{fe}}$	Forward Transconductance ④	6.1	10	—	S	$V_{\text{CE}} = 100\text{V}$ , $I_C = 17\text{A}$
$I_{\text{CES}}$	Zero Gate Voltage Collector Current	—	—	250	$\mu\text{A}$	$V_{\text{GE}} = 0\text{V}$ , $V_{\text{CE}} = 600\text{V}$
		—	—	2500		$V_{\text{GE}} = 0\text{V}$ , $V_{\text{CE}} = 600\text{V}$ , $T_J = 150^\circ\text{C}$
$V_{\text{FM}}$	Diode Forward Voltage Drop	—	1.4	1.7	V	$I_F = 12\text{A}$ See Fig. 13
		—	1.3	1.6		$I_F = 12\text{A}$ , $T_J = 150^\circ\text{C}$
$I_{\text{GES}}$	Gate-to-Emitter Leakage Current	—	—	$\pm 100$	nA	$V_{\text{GE}} = \pm 20\text{V}$

## Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

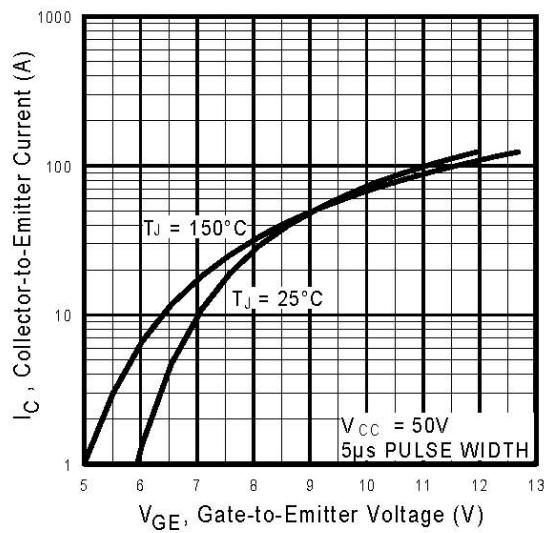
	Parameter	Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge (turn-on)	—	51	77	nC	$I_C = 17\text{A}$
$Q_{\text{ge}}$	Gate-to-Emitter Charge (turn-on)	—	7.9	12		$V_{\text{CC}} = 400\text{V}$ See Fig. 8
$Q_{\text{gc}}$	Gate-to-Collector Charge (turn-on)	—	19	28		$V_{\text{GE}} = 15\text{V}$
$t_{d(\text{on})}$	Turn-On delay time	—	42	—	ns	$T_J = 25^\circ\text{C}$
$t_r$	Rise time	—	26	—		$I_C = 17\text{A}$ , $V_{\text{CC}} = 480\text{V}$
$t_{d(\text{off})}$	Turn-Off delay time	—	230	350		$V_{\text{GE}} = 15\text{V}$ , $R_G = 23\Omega$
$t_f$	Fall time	—	160	230	mJ	Energy losses include "tail" and diode reverse recovery. See Fig. 9, 10, 11, 18
$E_{\text{on}}$	Turn-On Switching Loss	—	0.63	—		
$E_{\text{off}}$	Turn-Off Switching Loss	—	1.39	—		
$E_{\text{ts}}$	Total Switching Loss	—	2.02	3.9	ns	
$t_{d(\text{on})}$	Turn-On delay time	—	42	—		$T_J = 150^\circ\text{C}$ See Fig. 9, 10, 11, 18
$t_r$	Rise time	—	27	—		$I_C = 17\text{A}$ , $V_{\text{CC}} = 480\text{V}$
$t_{d(\text{off})}$	Turn-Off delay time	—	310	—		$V_{\text{GE}} = 15\text{V}$ , $R_G = 23\Omega$
$t_f$	Fall time	—	310	—	mJ	Energy losses include "tail" and diode reverse recovery.
$E_{\text{ts}}$	Total Switching Loss	—	3.2	—		
$L_E$	Internal Emitter Inductance	—	7.5	—		Measured 5mm from package
$C_{\text{ies}}$	Input Capacitance	—	1100	—	pF	$V_{\text{GE}} = 0\text{V}$
$C_{\text{oes}}$	Output Capacitance	—	74	—		$V_{\text{CC}} = 30\text{V}$ See Fig. 7
$C_{\text{res}}$	Reverse Transfer Capacitance	—	14	—		$f = 1.0\text{MHz}$
$t_{rr}$	Diode Reverse Recovery Time	—	42	60	ns	$T_J = 25^\circ\text{C}$ See Fig.
		—	80	120		$T_J = 125^\circ\text{C}$ 14
$I_{rr}$	Diode Peak Reverse Recovery Current	—	3.5	6.0	A	$T_J = 25^\circ\text{C}$ See Fig.
		—	5.6	10		$T_J = 125^\circ\text{C}$ 15
$Q_{rr}$	Diode Reverse Recovery Charge	—	80	180	nC	$T_J = 25^\circ\text{C}$ See Fig.
		—	220	600		$T_J = 125^\circ\text{C}$ 16
$di_{(\text{rec})M}/dt$	Diode Peak Rate of Fall of Recovery During $t_b$	—	180	—	A/ $\mu\text{s}$	$T_J = 25^\circ\text{C}$ See Fig.
		—	120	—		$T_J = 125^\circ\text{C}$ 17



**Fig. 1** - Typical Load Current vs. Frequency  
 (Load Current =  $I_{RMS}$  of fundamental)



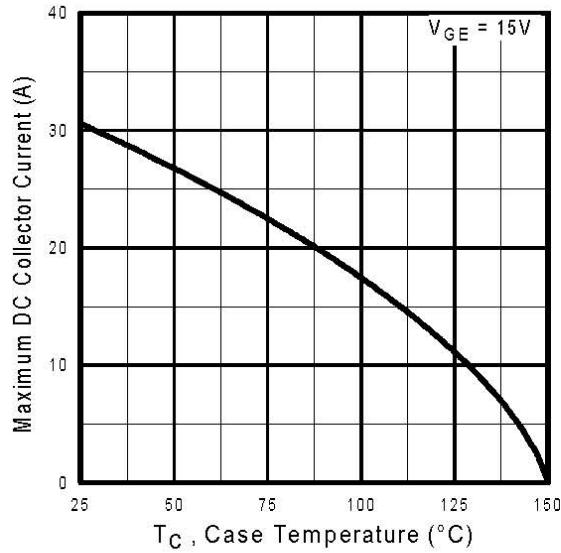
**Fig. 2** - Typical Output Characteristics



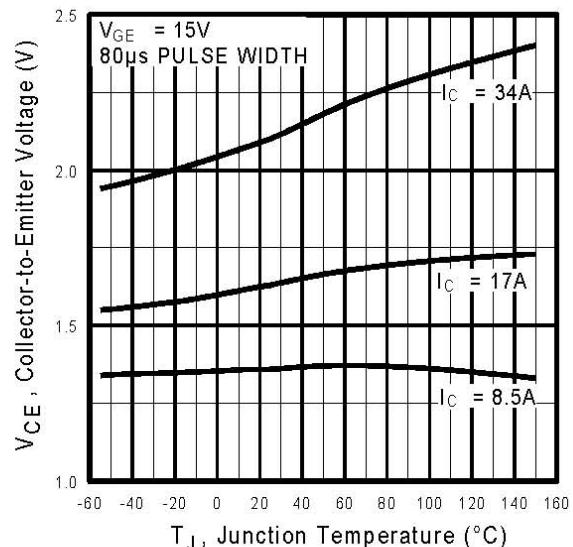
**Fig. 3** - Typical Transfer Characteristics

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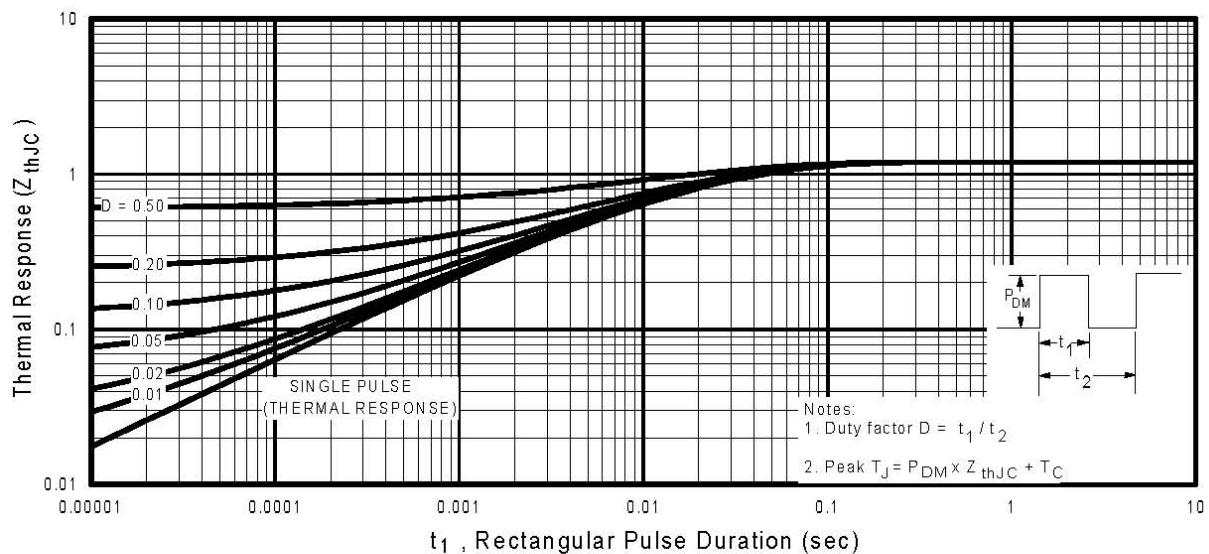
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**Fig. 4** - Maximum Collector Current vs. Case Temperature

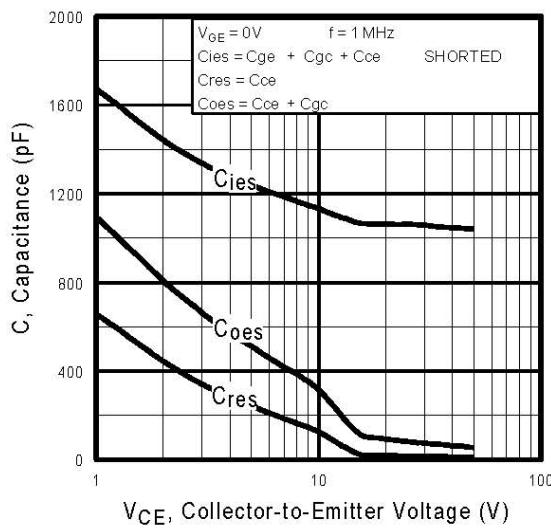


**Fig. 5** - Typical Collector-to-Emitter Voltage vs. Junction Temperature

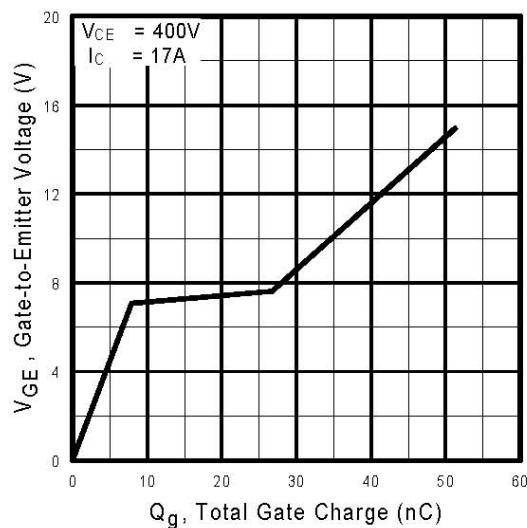


**Fig. 6** - Maximum Effective Transient Thermal Impedance, Junction-to-Case

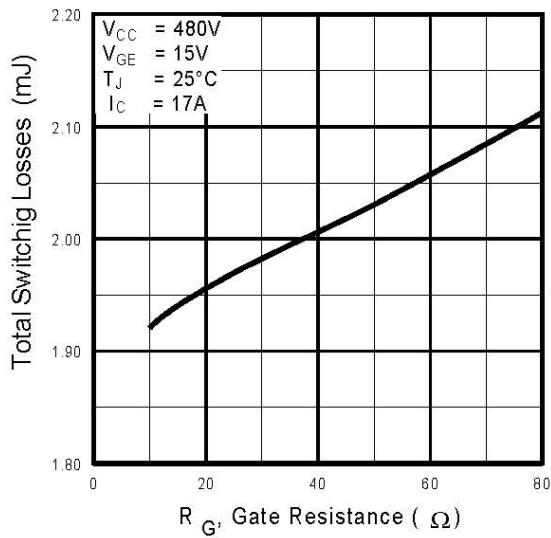
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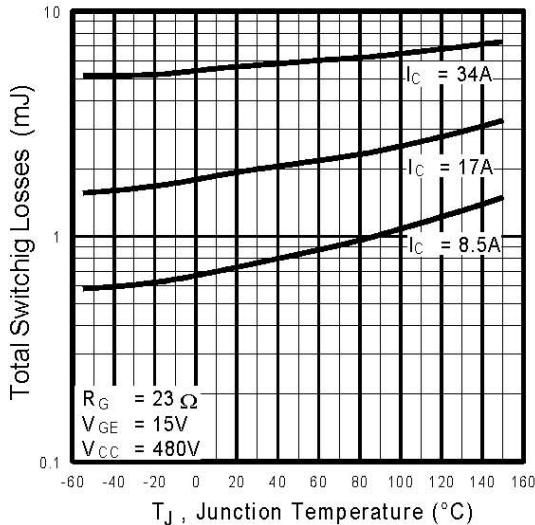
**Fig. 7** - Typical Capacitance vs.  
Collector-to-Emitter Voltage



**Fig. 8** - Typical Gate Charge vs.  
Gate-to-Emitter Voltage



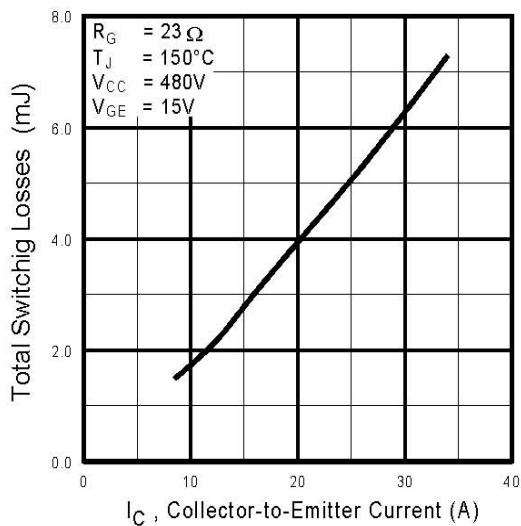
**Fig. 9** - Typical Switching Losses vs.  
Gate Resistance



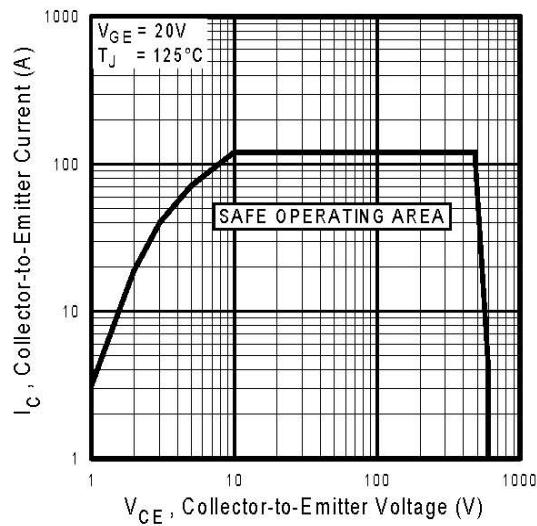
**Fig. 10** - Typical Switching Losses vs.  
Junction Temperature

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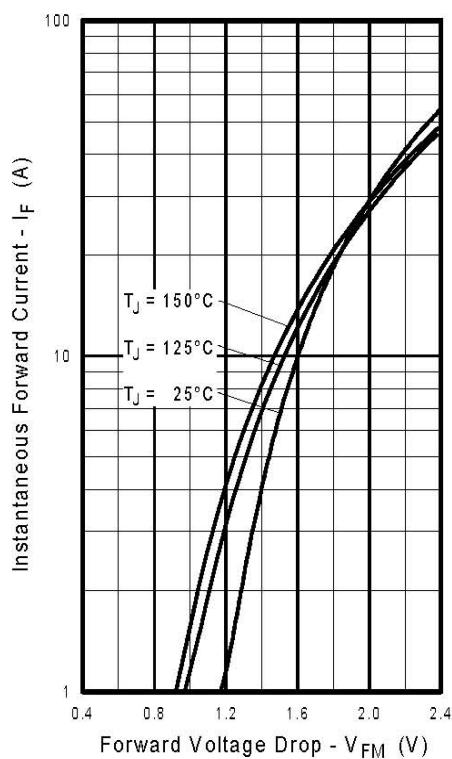
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**Fig. 11** - Typical Switching Losses vs.  
Collector-to-Emitter Current

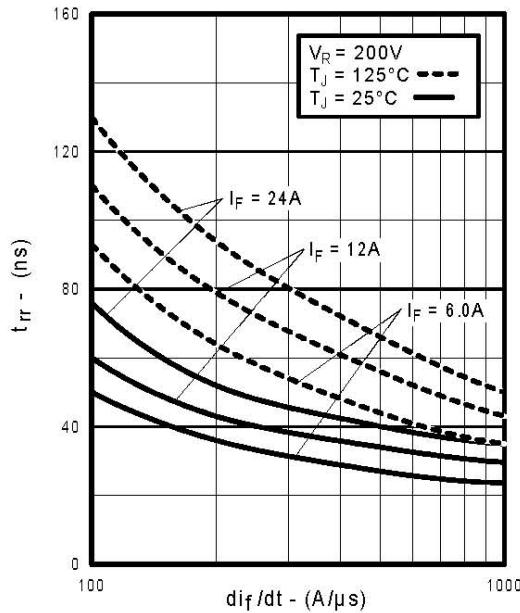


**Fig. 12** - Turn-Off SOA

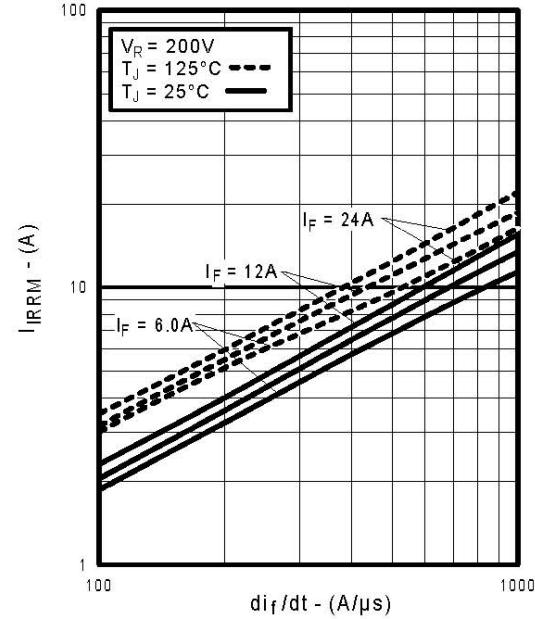


**Fig. 13** - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

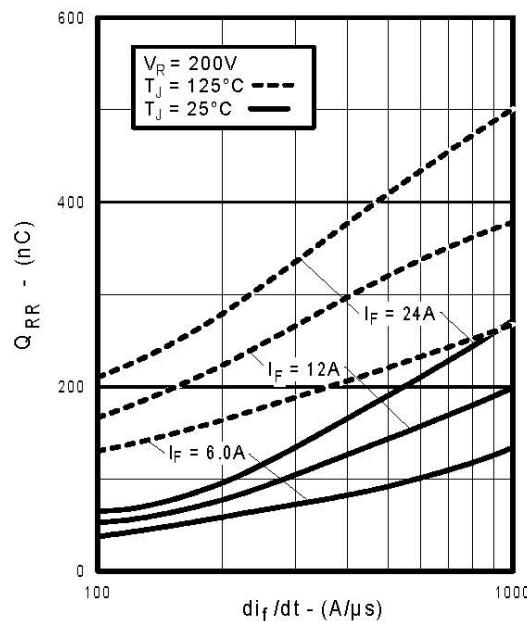
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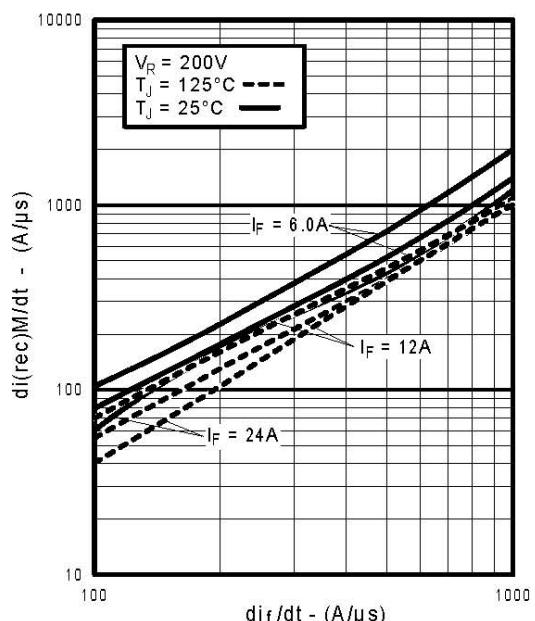
**Fig. 14** - Typical Reverse Recovery vs.  $di_f/dt$



**Fig. 15** - Typical Recovery Current vs.  $di_f/dt$



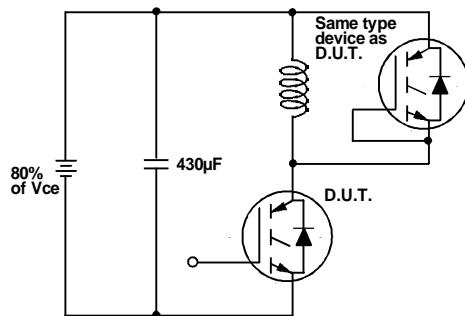
**Fig. 16** - Typical Stored Charge vs.  $di_f/dt$



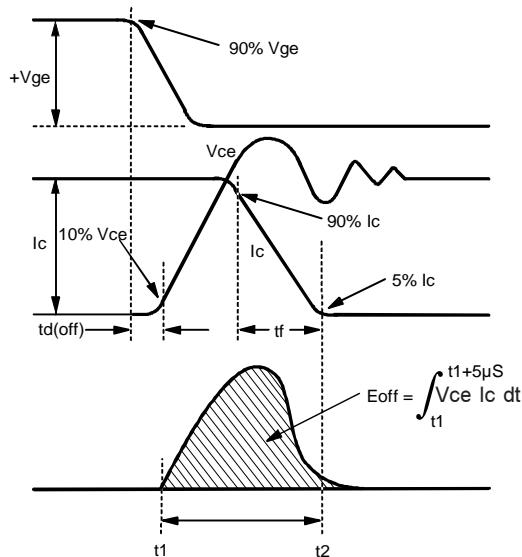
**Fig. 17** - Typical  $d(di_{rec})/dt$  vs.  $di_f/dt$

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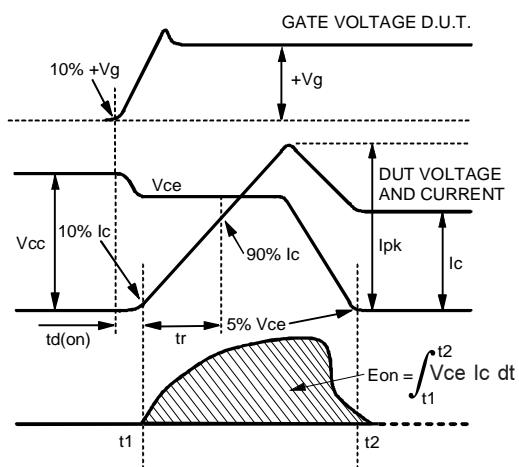
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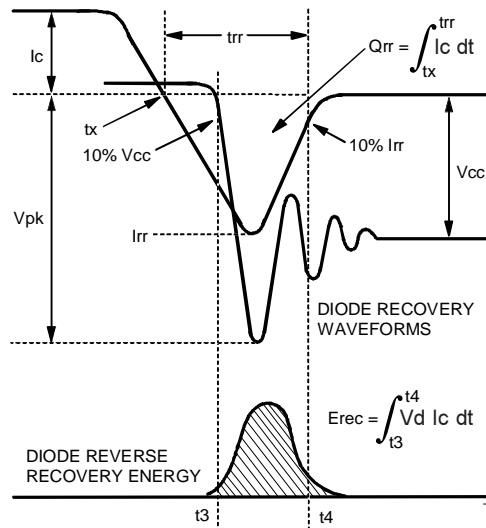
**Fig. 18a** - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off(diode)}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_d(on)$ ,  $t_r$ ,  $t_d(off)$ ,  $t_f$



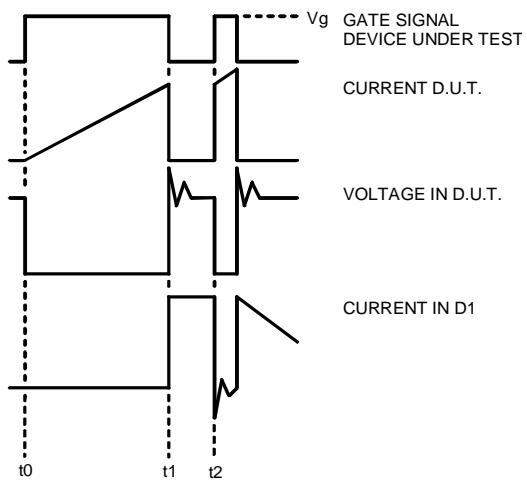
**Fig. 18b** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$



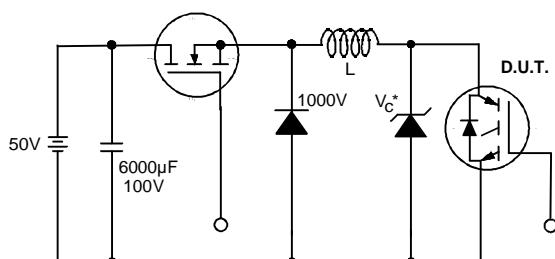
**Fig. 18c** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$



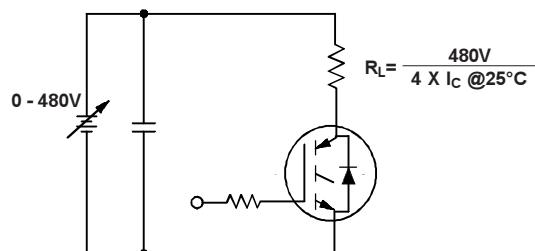
**Fig. 18d** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{rec}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$



**Fig.18e** - Macro Waveforms for Figure 18a's Test Circuit



**Fig. 19** - Clamped Inductive Load Test Circuit

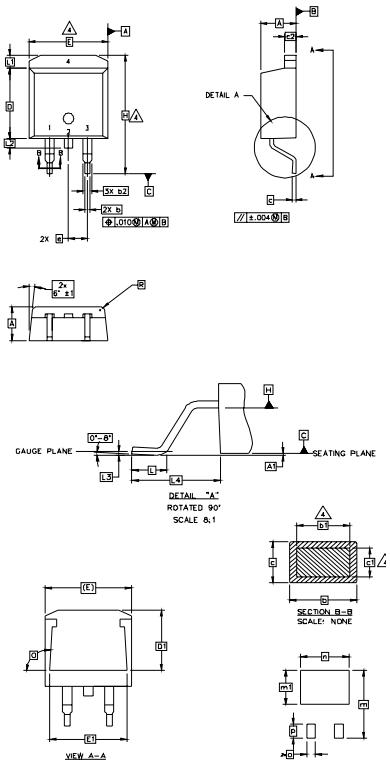


**Fig. 20** - Pulsed Collector Current Test Circuit

# IRG4BC30FD-SPbF

## D<sup>2</sup>Pak Package Outline

Dimensions are shown in millimeters (inches)



### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
5. CONTROLLING DIMENSION: INCH.

SYMBOL	DIMENSIONS				NOTES
	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
A	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	4
b2	1.14	1.78	.045	.070	
c	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	4
c2	1.14	1.65	.045	.065	
D	8.51	9.65	.335	.380	3
D1	6.86		.270		
E	9.65	10.67	.380	.420	3
E1	6.22		.245		
e	2.54	BSC	.100	BSC	
H	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1		1.65		.065	
L2	1.27	1.78	.050	.070	
L3	0.25	BSC	.010	BSC	
L4	4.78	5.28	.188	.208	
m	17.78		.700		
m1	8.89		.350		
n	11.43		.450		
o	2.08		.082		
p	3.81		.150		
R	0.51	0.71	.020	.028	
θ	90°	93°	90°	93°	

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### LEAD ASSIGNMENTS

#### HEXFET

- 1.- GATE
- 2, 4.- DRAIN
- 3.- SOURCE

### IGBTs, CoPACK

- 1.- GATE
- 2, 4.- COLLECTOR
- 3.- Emitter

### DIODES

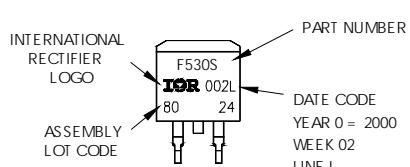
- 1.- ANODE \*
- 2, 4.- CATHODE
- 3.- ANODE

\* PART DEPENDENT.

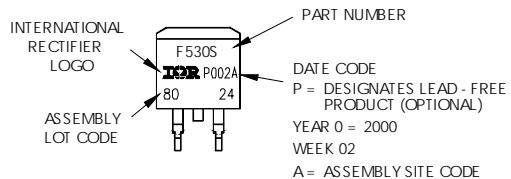
## D<sup>2</sup>Pak Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH  
LOT CODE 8024  
ASSEMBLED ON WW02, 2000  
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position  
indicates "Lead - Free"

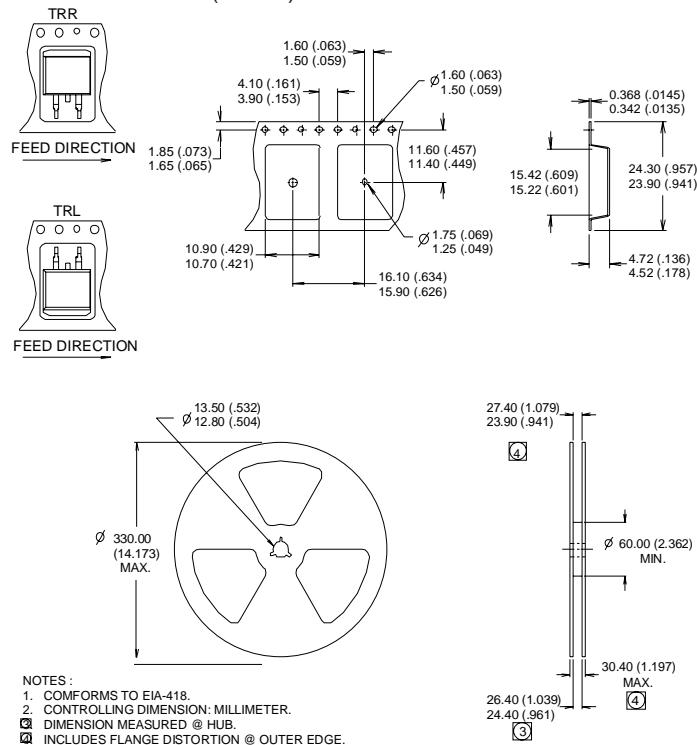


OR



## D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



## Notes:

- ① Repetitive rating:  $V_{GE}=20V$ ; pulse width limited by maximum junction temperature (figure 20).
  - ②  $V_{CC}=80\%(V_{CES})$ ,  $V_{GE}=20V$ ,  $L=10\mu H$ ,  $R_G = 23\Omega$  (figure 19).
  - ③ Pulse width  $\leq 80\mu s$ ; duty factor  $\leq 0.1\%$ .
  - ④ Pulse width  $5.0\mu s$ , single shot.
  - ⑤ When mounted on 1" square PCB (FR-4 or G-10 Material).

Data and specifications subject to change without notice.

# International **IR** Rectifier

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Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>